

<b>Notice of References Cited</b>	Application/Control No. 10/519,766		Applicant(s)/Patent Under Reexamination SCHULTHEIS ET AL.	
	Examiner DAVID BANH		Art Unit 2854	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,784,957 A	07-1998	Rau et al.	101/142
*	B	US-2001/0050019 A1	12-2001	Ezaki et al.	101/488
*	C	US-2004/0011234 A1	01-2004	Figov et al.	101/488
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	P					
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**NON-PATENT DOCUMENTS**

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